

Portable device

According to §15.247(e)(i) and §1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines.

According to KDB447498 D01 General RF Exposure Guidance V06

The 1-g SAR and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq 50$  mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0$  for 1-g SAR and  $\leq 7.5$  for 10-g extremity SAR, where:

- $f(\text{GHz})$  is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison

When the minimum test separation distance is  $< 5$  mm, a distance of 5 mm is applied to determine SAR test exclusion.

BT:

Modulation	Channel Freq. (GHz)	Conduct ed power (dBm)	Conducte d power (mW)	Tune-up power (dBm)	Max tune-up power (dBm)	Max tune-up power (mW)	Distance (mm)	Result calculation	SAR Exclusion threshold	SAR test exclusion
GFSK	2.402	2.76	1.89	2±1	3	2.00	<5	0.61847	3.00	YES
	2.441	2.56	1.80	2±1	3	2.00	<5	0.62347	3.00	YES
	2.480	1.66	1.47	2±1	3	2.00	<5	0.62843	3.00	YES
$\pi/4$ -DQPSK	2.402	3.52	2.25	3±1	4	2.51	<5	0.77860	3.00	YES
	2.441	3.37	2.17	3±1	4	2.51	<5	0.78490	3.00	YES
	2.480	2.5	1.78	3±1	4	2.51	<5	0.79114	3.00	YES
BLE 1M	2.402	2.89	1.95	2±1	3	2.00	<5	0.61847	3.00	YES
	2.440	2.76	1.89	2±1	3	2.00	<5	0.62334	3.00	YES
	2.480	1.84	1.53	2±1	3	2.00	<5	0.62843	3.00	YES
BLE 2M	2.402	2.99	1.99	2±1	3	2.00	<5	0.61847	3.00	YES
	2.440	2.77	1.89	2±1	3	2.00	<5	0.62334	3.00	YES
	2.480	1.84	1.53	2±1	3	2.00	<5	0.62843	3.00	YES

**Conclusion:**

For the max result :  $0.79114 \leq 3.0$  for 1g SAR, SAR is not required.

**Signature:**

*Alex Li*

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**NAME AND TITLE** (Please print or type): Alex Li/Manager

**COMPANY** (Please print or type): Shenzhen NTEK Testing Technology Co., Ltd./ No. 24 Xinfu East Road, Xiangshan Community, Xinqiao Street, Baoan District, Shenzhen, Guangdong, People's Republic of China